

<b>Notice of References Cited</b>	Application/Control No. 10/590,591		Applicant(s)/Patent Under Reexamination CADEE ET AL.	
	Examiner NINA A. ARCHIE		Art Unit 1645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,340,924	08-1994	Tomita et al.	530/395
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO/2000/72874A1	12-2000		Naidu et al	
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	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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